Se	arch Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination
10/668,582	STUFFLET ET AL.
Examiner	Art Unit
Leila Malek	2611

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Class	Subclass	Date	Examiner
375	220	2/16/2007	L.M
375	295	2/16/2007	L.M
375	296	2/16/2007	L.M

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	2/16/2007	L.M	
IEEE	2/16/2007	L.M	
GOOGLE	2/16/2007	L.M	
Consulted M. Ghayour	2/16/2007	L.M	
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